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- Four Independent Receivers With Common Enable Input
- High Input Sensitivity . . . 25 mV Max
- High Input Impedance
- MC3450 and MC3550 Have 3-State Outputs
- MC3452 Has Open-Collector Outputs
- Glitch-Free Power-Up/Power-Down Operation

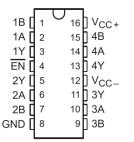
description

The MC3450, MC3550, MC3452, and MC3552 are quad differential line receivers designed for use in balanced and unbalanced digital data transmission. The MC34/3550 and MC34/3552 are the same except that the MC3450 and MC3550 have 3-state outputs whereas the MC3452 and MC3552 have open-collector outputs, which permit the wire-AND function with similar output devices. The 3-state and open-collector outputs permit connection directly to a bus-organized system.

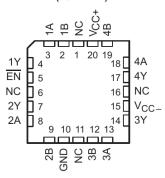
The MC3450, MC3550, MC3452, and MC3550 are designed for optimum performance when used with either the MC3453 or MC3553 quad differential line driver or SN75109A, SN75110A, and SN75112 dual differential drivers.

The MC3450 and MC3452 are characterized for operation from $0 \circ C$ to $70 \circ C$. The MC3550 and MC3552 are characterized for operation over the full military temperature range of $-55 \circ C$ to $125 \circ C$.

MC3450, MC3452...D OR N PACKAGE MC3550, MC3552...J PACKAGE (TOP VIEW)



MC3550, MC3552 . . . FK PACKAGE (TOP VIEW)



NC-No internal connection

THE MC3452 IS NOT RECOMMENDED FOR NEW DESIGN

FUNCTION TABLE

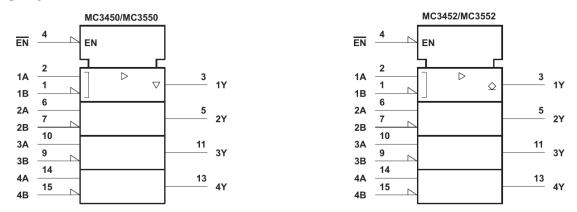
DIFFERENTIAL INPUTS A – B	ENABLE EN	OUTPUT Y
$V_{ID} \ge 25 \text{ mV}$	L	Н
-25 mV < V _{ID} < 25 mV	L	?
$V_{ID} \leq 25 \text{ mV}$	L	L
X	Н	Z

H = high level, L = low level, ? = indeterminate,

X = impedance (off)

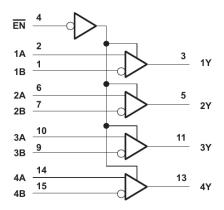
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logic symbols†



[†]These symbols are in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12.

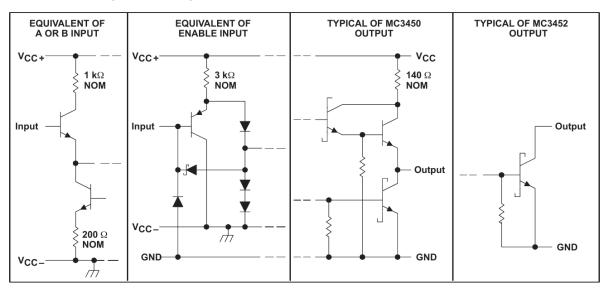
logic diagram (positive logic)





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schematics of inputs and outputs



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)

Supply voltage, V _{CC+} (see Note 1)	7 V
Supply voltage, V _{CC}	
Differential input voltage (see Note 2)	±6 V
Common-mode input voltage (see Note 3)	±5 V
Enable input voltage	5.5 V
Continuous total dissipation	See Dissipation Rating Table
Operating free-air temperature range	0°C to 70°C
Storage temperature range	−65°C to 150°C
Case temperature for 60 seconds: FK package	260°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds: D or N package	ge 260°C
Lead temperature 1,6 mm (1/16 inch) from case for 60 seconds: J package .	300°C

NOTES: 1. All voltage values, except differential input voltage, are with respect to network ground terminal.

- 2. Differential input voltage is measured at the noninverting input with respect to the corresponding inverting input.
- 3. Common-mode input voltage is the average of the voltages at the A and B inputs.

DISSIPATION RATING TABLE

PACKAGE	T _A ≤25∘C POWER RATING	OPERATING FACTOR ABOVE T _A = 25°C	T _A = 70∘C POWER RATING	T _A = 125∘C POWER RATING		
D	950 mW	7.6 mW/∘C	608 mW	_		
FK	1375 mW	11.0 mW/∘C	880 mW	275 mW		
J	1375 mW	11.0 mW/∘C	880 mW	275 mW		
N	1150 mW	9.2 mW/∘C	736 mW	_		



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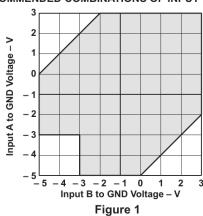
recommended operating conditions

		MIN	NOM	MAX	UNIT	
Supply voltage, V _{CC+}	T _A ≥25∘C	4.5	5	5.5	V	
	T _A < 25∘C	4.75	5	5.5	V	
Supply voltage, V _{CC} _	T _A ≥25∘C	-4.5	-5	-5.5	V	
	T _A < 25∘C	-4.75	-5	-5.5	V	
High-level enable input voltage, VIH					V	
Low-level enable input voltage, V _{IL}			0.8	V		
Low-level output current, IOL			-16	mA		
Differential input voltage, V _{ID} (see Note	-5 [†]		5	V		
Common-mode input voltage, V _{IC} (see Note 4)				3	V	
Input voltage range, any different input to GND				3	V	
Operating free-air temperature, T _A	MC3450, MC3452	0		70	∘C	
Operating free-air temperature, 1A	MC3550, MC3552	-55		125	30	

[†] The algebraic convention, in which the less positive (more negative) limit is designated minimum, is used in this data sheet for common-mode input voltage.

NOTE 4: The recommended combinations of input voltages fall within the shaded area of Figure 1.

RECOMMENDED COMBINATIONS OF INPUT VOLTAGES



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electrical characteristics over recommended operating free-air temperature range, $V_{CC\,\pm}$ = MAX (unless otherwise noted)

PARAMETER		TEST CONDITIONS		MC3450, MC3550			MC3452, MC3552			UNIT			
	FARAMETER		TEST CON	MIN	TYP†	MAX	MIN	TYP†	MAX	UNII			
Vон	High-level outpu	High-level output voltage		V_{ID} = 25 mV, I_{OH} = - 400 μ A,	2.4						V		
V _{OL}	Low-level output voltage		$\frac{V_{CC} \pm = \pm 4.75 \text{ V,}}{\text{EN at 2 V,}}$ V _{IC} = -3 V to 3 V	V_{ID} = -25 mV, I_{OL} = 16 mA,			0.5			0.5	٧		
loH	High-level outpu	t current	$V_{CC \pm} = \pm 4.75 V$,	V _{OH} = 5.25 V						250	μΑ		
		A inputs	V _{ID} = -2 V			30	75		30	75	μА		
ļ	High-level input current	B inputs	V _{ID} = -2 V			30	75		30	75	μΑ		
lηΗ		===	V _{IH} = 2.4 V				40			40	μΑ		
			ĒN	V _{IH} = 5.25 V				1			1	mA	
	Low-level	Low-level input current		A inputs	V _{ID} = 2 V				-10			-10	μА
I _I L			B inputs	V _{ID} = 2 V				-10			-10	μΑ	
	input current		V _{IL} = 0.4 V				-1.6			-1.6	mA		
lo-	High-impedance state output current		V _O = 2.4 V				40				μА		
102			V _O = 0.4 V				-40				μΑ		
los	Short-circuit output current‡		V _{ID} = 25 mV, EN at 0.8 V	V _O = 0,	-18		-70				mA		
ICCH+	Supply current fro outputs high	om V _{CC+} ,	A inputs at GND,	B inputs at 3 V,			60			60	mA		
ICCH-	Supply current from V_{CC-} , outputs high		_, EN at 3 V				- 30	·	·	-30	mA		

[†] All typical values are at V_{CC+} = 5 V, V_{CC-} = -5 V, T_A = 25 °C. ‡ Not more than one output should be shorted at a time.

switching characteristics, V_{CC \pm}– \pm 5 V, T_A = 25 \circ C

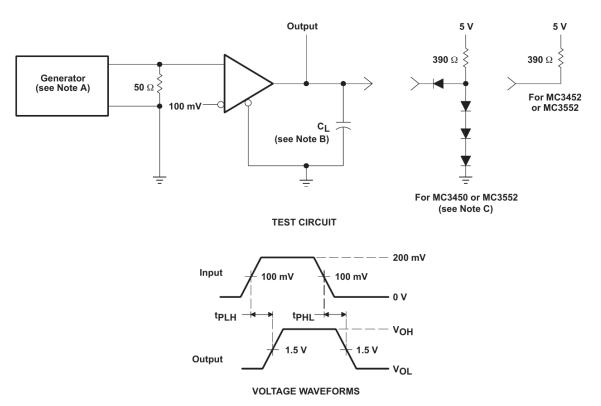
DADAMETED	FROM	TO	TEST CONDITIONS -		MC3450, MC3550			MC3452, MC3552			LINUT		
PARAMETER	(INPUT)	(OUTPUT)			MIN	TYP†	MAX	MIN	TYP†	MAX	UNIT		
tour	A and B	Υ	$C_L = 50 pF$,	See Figure 2		17	25				ns		
^t PLH	A allu b	,	C _L = 15 pF,	See Figure 2					19	25	115		
to	A and B	Υ	$C_L = 50 pF$,	See Figure 2		17	25				ns		
^t PHL	A and b	A and b	A and b	ľ	$C_L = 15 pF$,	See Figure 2					19	25	115
t _{PZH}	EN	Υ	C _L = 50 pF,	C: = 50 pE	See Figure 2			21				ns	
t _{PZL}	EN	Υ		See Figure 2			27				115		
t _{PHZ}	EN	Υ	C: = 45 = 5	See Figure 3			18				ns		
tPLZ	EN	Υ	C _L = 15 pF,	See Figure 3			29				115		
t _{PLH}	EN	Υ	$C_L = 15 pF$,	See Figure 4						25	ns		
t _{PHL}	EN	Υ	C _L = 15 pF,	See Figure 4					•	25	ns		

[†] All typical values are at $V_{CC+} = 5 \text{ V}$, $V_{CC-} = -5 \text{ V}$, $T_A = 25 \text{ °C}$.



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PARAMETER MEASUREMENT INFORMATION



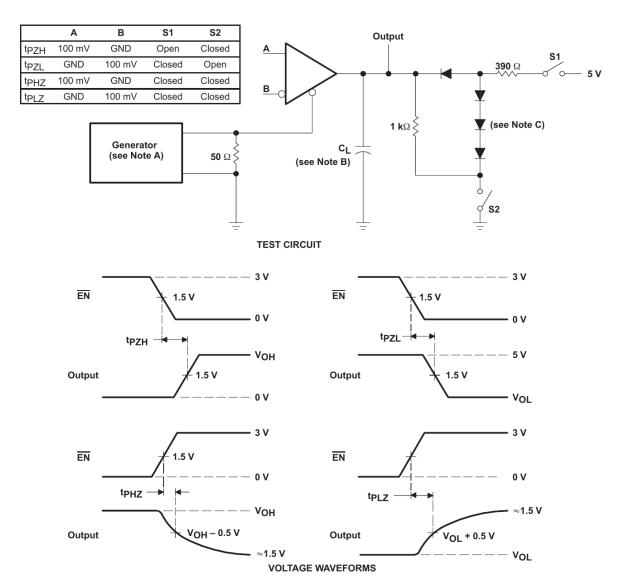
NOTES: A. The input pulse is supplied by a generator having the following characteristics: PRR \leq 1 MHz, duty cycle = 50%, $t_{\Gamma} \leq$ 6 ns, $t_{\Gamma} \leq$ 6 ns.

- B. CL includes probe and jig capacitance.
- C. All diodes are 1N916 or equivalent.

Figure 2. Test Circuit and Voltage Waveforms



PARAMETER MEASUREMENT INFORMATION



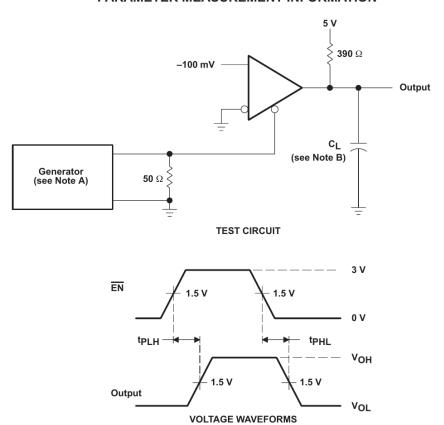
NOTES: A. The input pulse is supplied by a generator having the following characteristics: PRR \leq 1 MHz, duty cycle = 50%, $t_f \leq$ 6 ns. $t_f \leq$ 6 ns.

- B. C_L includes probe and jig capacitance.
- C. All diodes are 1N916 or equivalent.

Figure 3. MC3450 and MC3550 Test Circuit and Voltage Waveforms



PARAMETER MEASUREMENT INFORMATION



NOTES: A. The input pulse is supplied by a generator having the following characteristics: PRR \leq 1 MHz, duty cycle = 50%, $t_f \leq$ 6 ns, $t_f \leq$ 6 ns.

B. C_L includes probe and jig capacitance.

Figure 4. MC3452 and MC3552 Test Circuit and Voltage Waveforms



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